

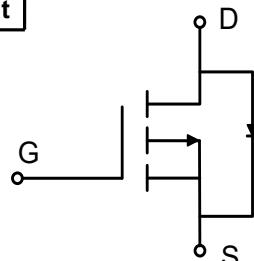
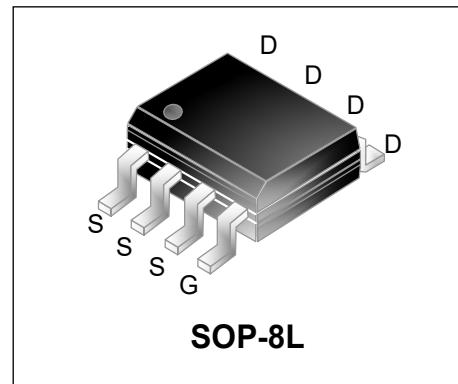
## 20V P-Channel Enhancement Mode Power MOSFET

### Description

WMS15P02T1 uses advanced power trench technology that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

### Features

- $V_{DS} = -20V$ ,  $I_D = -15A$   
 $R_{DS(on)} < 8.2m\Omega$  @  $V_{GS} = -4.5V$   
 $R_{DS(on)} < 10m\Omega$  @  $V_{GS} = -2.5V$
- Green Device Available
- Low Gate Charge
- Advanced High Cell Density Trench Technology
- 100% EAS Guaranteed



### Applications

- Power Management Switches
- DC/DC Converter

### Absolute Maximum Ratings ( $T_A = 25^\circ C$ , unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	-20	V
Gate-Source Voltage	$V_{GS}$	$\pm 10$	V
Continuous Drain Current  $T_A=25^\circ C$	$I_D$	-15	A
		-9.5	
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	-60	A
Single Pulse Avalanche Energy <sup>1</sup>	$EAS$	61.25	mJ
Total Power Dissipation	$P_D$	3.1	W
Operating Junction and Storage Temperature Range	$T_J$ , $T_{STG}$	-55 to 150	$^\circ C$

### Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction-to-Ambient <sup>3</sup>	$R_{\theta JA}$	40	$^\circ C/W$

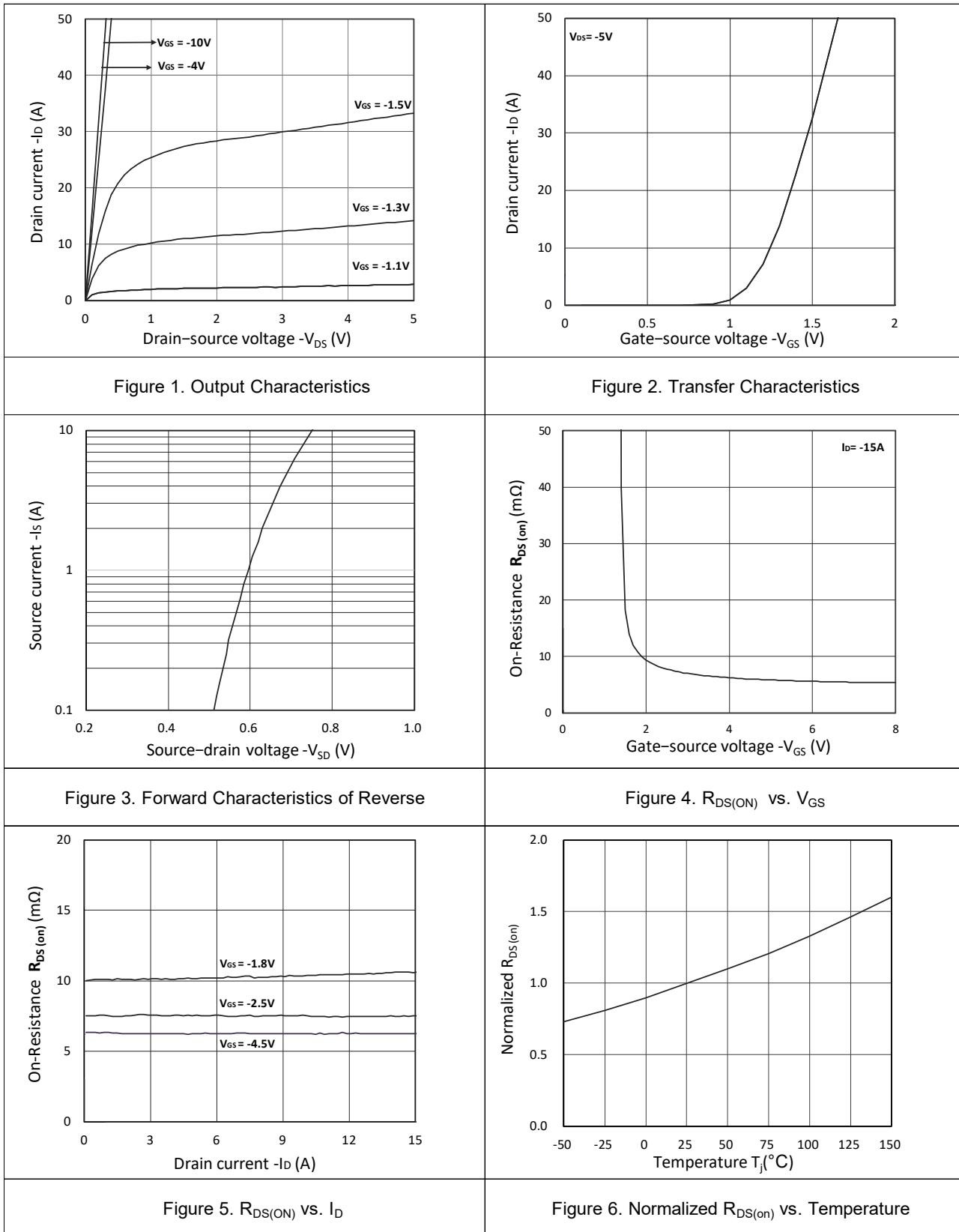
**Electrical Characteristics ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = -250\mu\text{A}$	-20	-	-	V
Gate-body Leakage current	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 10V$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current $T_J=25^\circ\text{C}$ $T_J=100^\circ\text{C}$	$I_{DS}$	$V_{DS} = -20V, V_{GS} = 0V$	-	-	-1	$\mu\text{A}$
			-	-	-100	
Gate-Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-0.4	-0.65	-1.0	V
Drain-Source On-Resistance <sup>4</sup>	$R_{DS(on)}$	$V_{GS} = -4.5V, I_D = -15\text{A}$	-	6	8.2	$\text{m}\Omega$
		$V_{GS} = -2.5V, I_D = -10\text{A}$	-	7.5	10	
		$V_{GS} = -1.8V, I_D = -8\text{A}$	-	10.2	15	
Forward Transconductance <sup>4</sup>	$g_{fs}$	$V_{DS} = -5V, I_D = -15\text{A}$	-	78	-	S
<b>Dynamic Characteristics<sup>5</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = -10V, V_{GS} = 0V, f = 1\text{MHz}$	-	3510	-	$\text{pF}$
Output Capacitance	$C_{oss}$		-	520	-	
Reverse Transfer Capacitance	$C_{rss}$		-	450	-	
Gate resistance	$R_g$	$f = 1\text{MHz}$	-	11	-	$\Omega$
<b>Switching Characteristics<sup>5</sup></b>						
Total Gate Charge	$Q_g$	$V_{GS} = -4.5V, V_{DS} = -10V, I_D = -15\text{A}$	-	43	-	$\text{nC}$
Gate-Source Charge	$Q_{gs}$		-	7.9	-	
Gate-Drain Charge	$Q_{gd}$		-	11.2	-	
Turn-on Delay Time	$t_{d(on)}$	$V_{GS} = -4.5V, V_{DD} = -10V, R_G = 3\Omega, I_D = -15\text{A}$	-	14.5	-	$\text{ns}$
Rise Time	$t_r$		-	20.2	-	
Turn-off Delay Time	$t_{d(off)}$		-	93	-	
Fall Time	$t_f$		-	161	-	
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = -15\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	-	28	-	$\text{ns}$
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	25.7	-	$\text{nC}$
<b>Drain-Source Body Diode Characteristics</b>						
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	$I_S = -1\text{A}, V_{GS} = 0V$	-	-	-1.2	V
Continuous Source Current	$I_S$	-	-	-	-15	A

Note :

1. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .
2. The EAS data shows Max. rating . The test condition is  $V_{DD} = -25V, V_{GS} = -10V, L = 0.1\text{mH}, I_{AS} = -35\text{A}$ .
3. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
4. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$ .
5. This value is guaranteed by design hence it is not included in the production test..

## Typical Characteristics



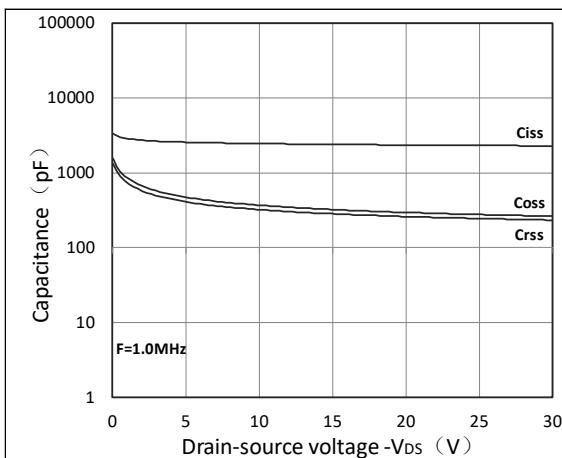


Figure 7. Capacitance Characteristics

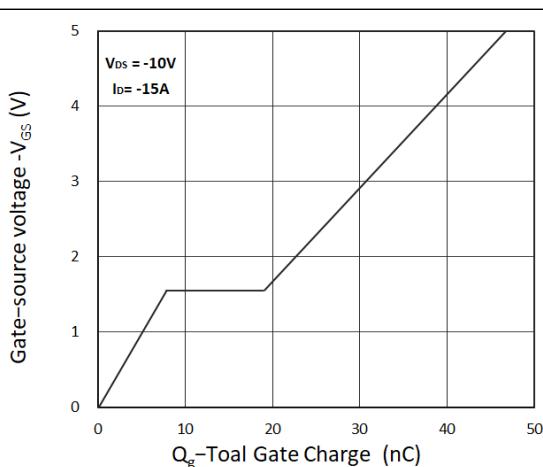


Figure 8. Gate Charge Characteristics

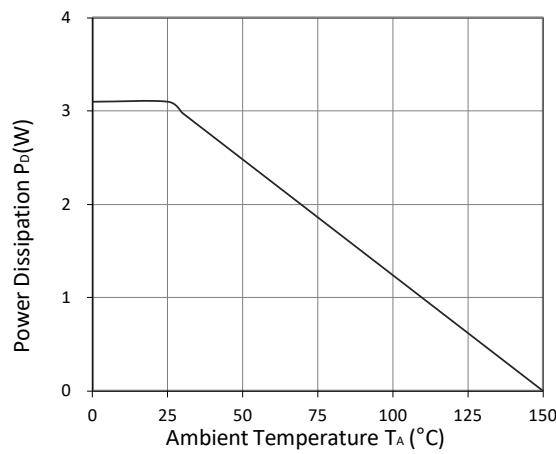


Figure 9. Power Dissipation

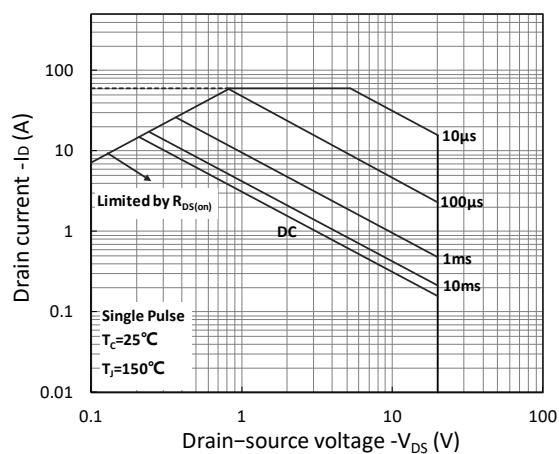


Figure 10. Safe Operating Area

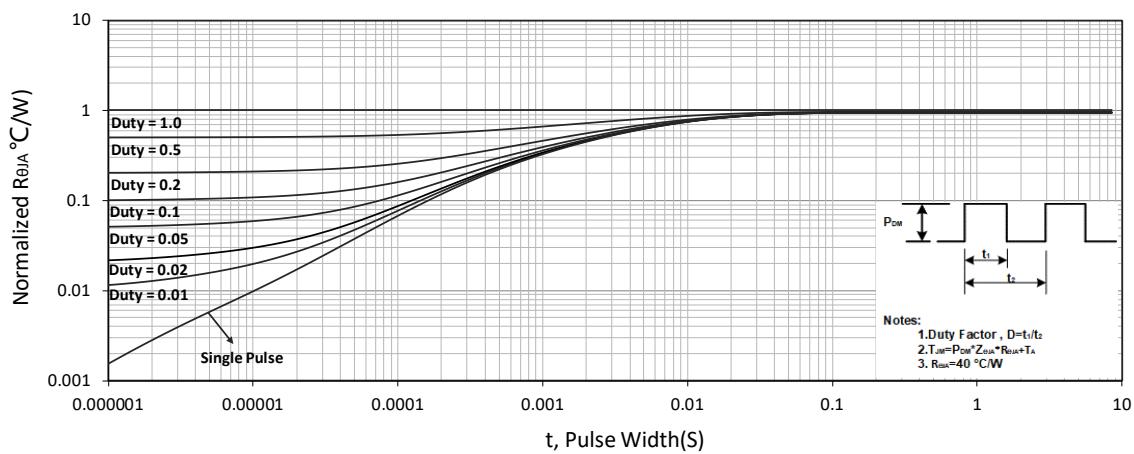
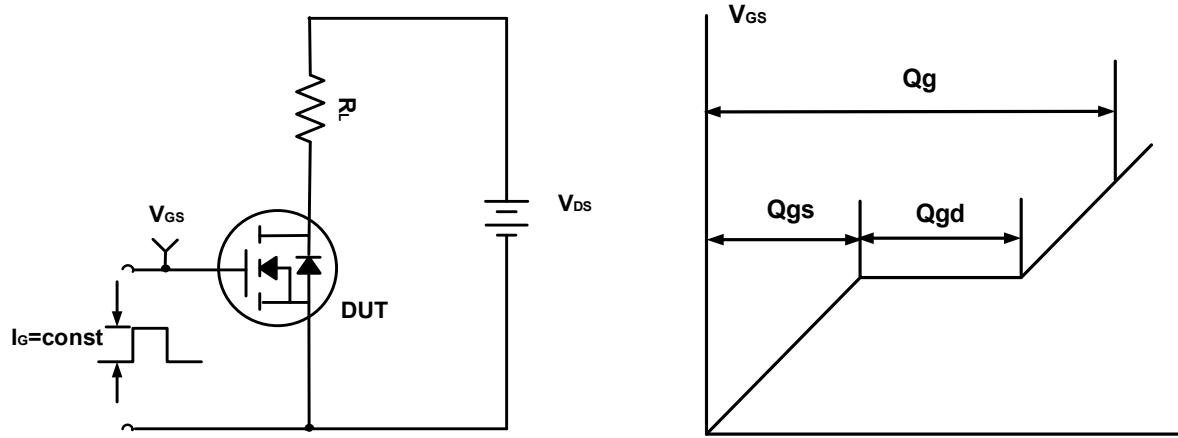
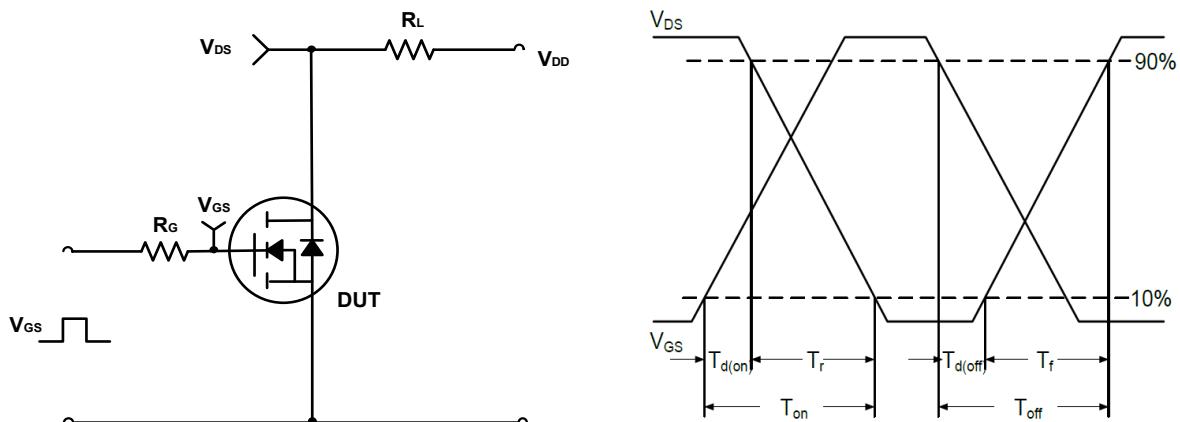
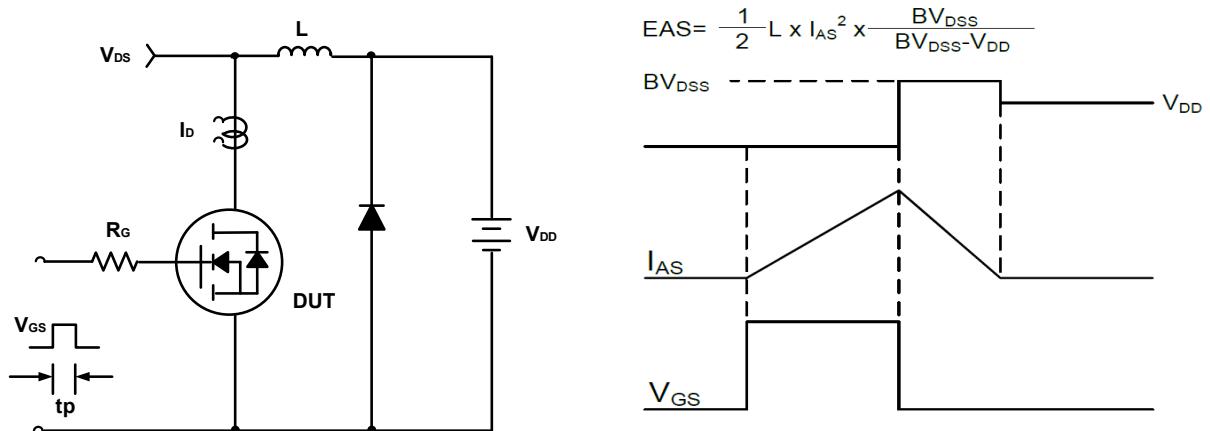
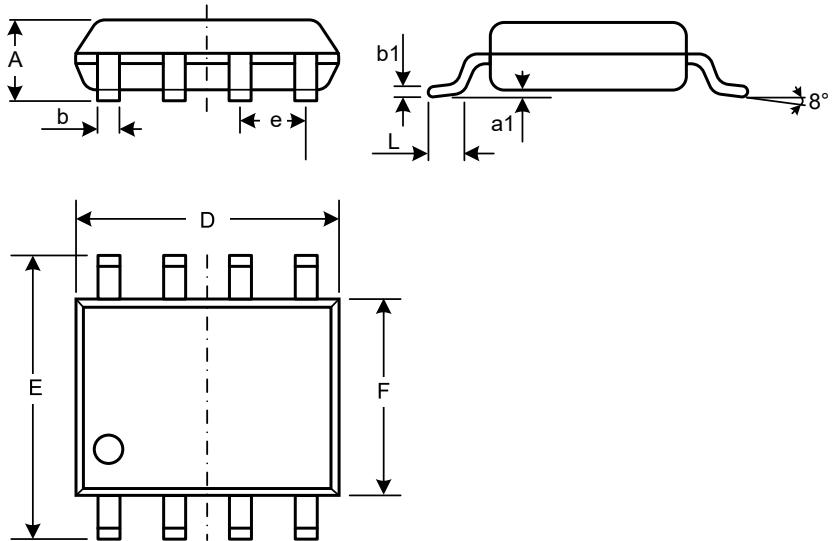


Figure 11. Normalized Maximum Transient Thermal Impedance

**Test Circuit****Figure A. Gate Charge Test Circuit & Waveforms****Figure B. Switching Test Circuit & Waveforms****Figure C. Unclamped Inductive Switching Circuit & Waveforms**

## Mechanical Dimensions for SOP-8L

## COMMON DIMENSIONS

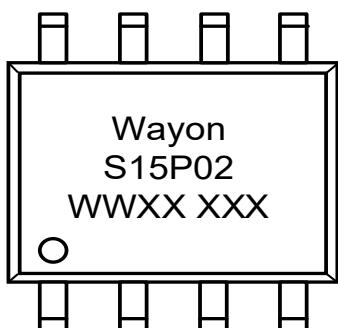


SYMBOL	MM	
	MIN	MAX
A	1.35	1.75
a1	0.05	0.25
b	0.31	0.51
b1	0.16	0.25
D	4.70	5.15
E	5.75	6.25
e	1.07	1.47
F	3.70	4.10
L	0.40	1.27

## Ordering Information

Part	Package	Marking	Packing method
WMS15P02T1	SOP-8L	S15P02	Tape and Reel

## Marking Information



S15P02= Device code  
WWXX XXX= Date code

## Contact Information

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